

3V to 8V Hot Swap Power Manager

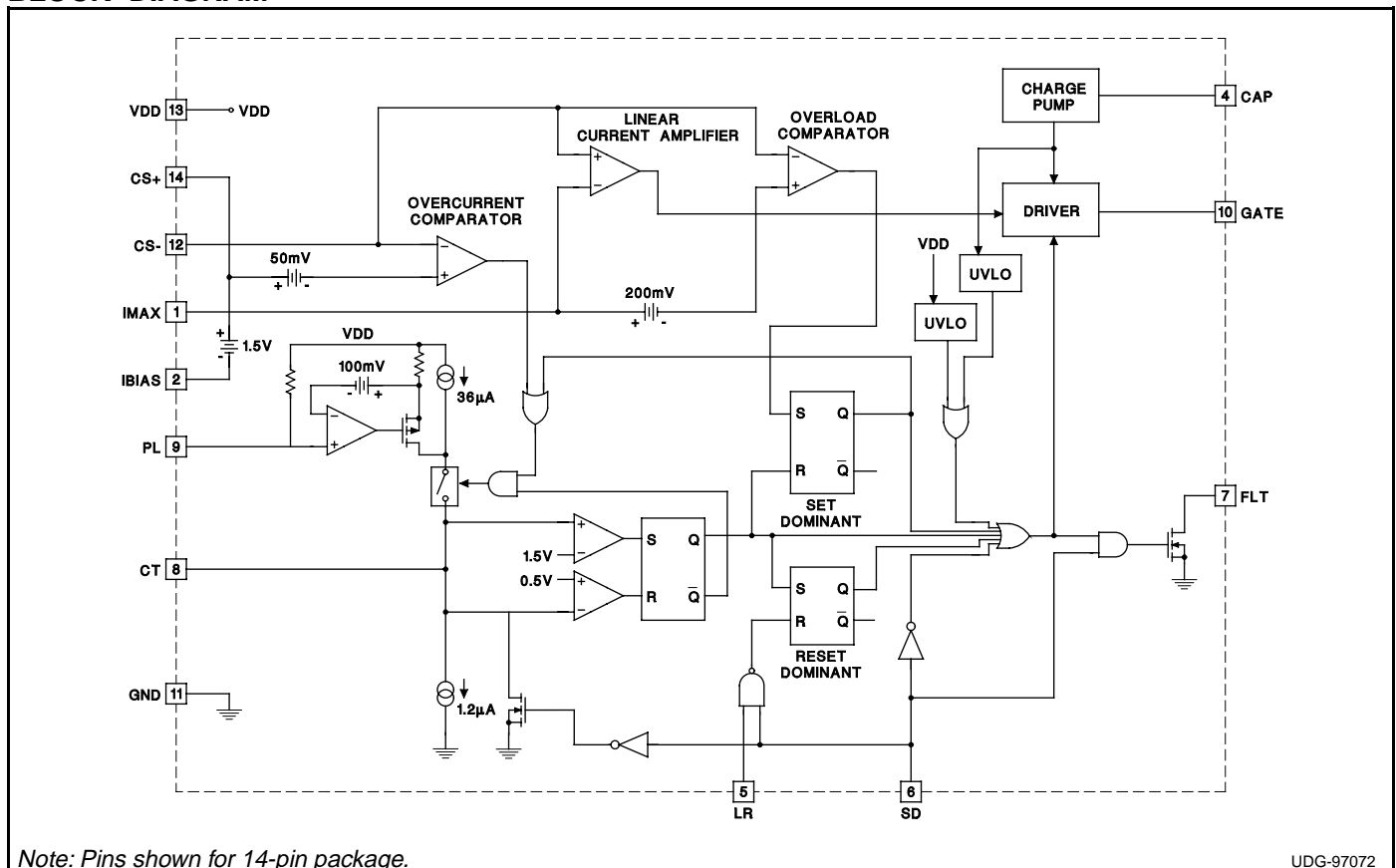
FEATURES

- Precision Fault Threshold
- Charge Pump for Low R_{DS(on)} High Side Drive
- Differential Sense Inputs
- Programmable Average Power Limiting
- Programmable Linear Current Control
- Programmable Fault Time
- Fault Output Indicator
- Manual and Automatic Reset Modes
- Shutdown Control
- Undervoltage Lockout
- Electronic Circuit Breaker Function

DESCRIPTION

The UCC3919 family of Hot Swap Power Managers provide complete power management, hot swap, and fault handling capability. The IC's include an on board charge pump to ensure low R_{DS(on)} high side drive. The UCC3919 features a duty ratio current limiting technique, which provides peak load capability while limiting the average power dissipation of the external pass transistor during fault conditions. The UCC3919 has two reset modes, selected with the TTL/CMOS compatible L/R pin. In one mode, when a fault occurs the IC repeatedly tries to reset itself at a user defined rate, with user defined maximum output current and pass transistor power dissipation. In the other mode the output latches off and stays off until either the L/R pin is reset or the shutdown pin is toggled. The on board charge pump circuit provides the necessary gate voltage for an external power FET.

BLOCK DIAGRAM



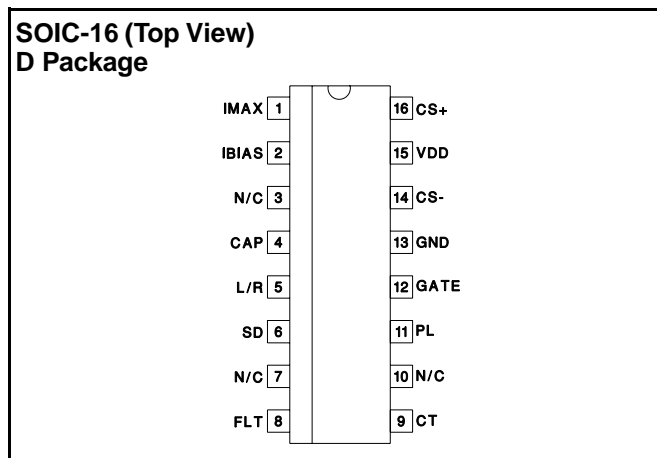
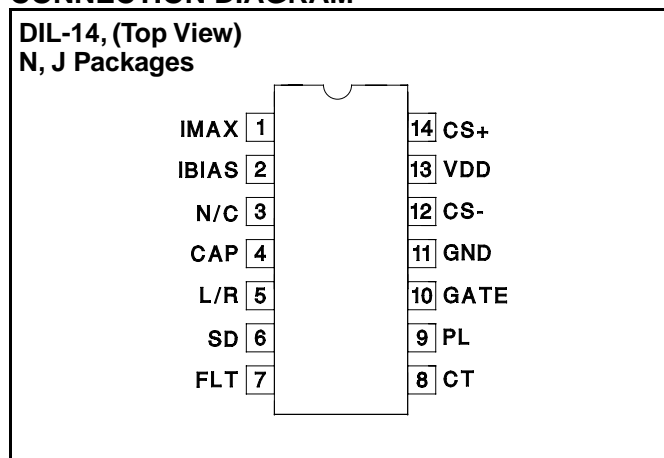
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ABSOLUTE MAXIMUM RATINGS

VDD	-0.3V to 10V
Pin Voltage (All pins except CAP and GATE)	-0.3V to VDD + 0.3V
Pin Voltage (CAP and GATE)	-0.3V to 15V
PL Current	0.5mA to -10mA
IBIAS Current	0mA to 3mA
Storage Temperature	-65°C to +150°C
Junction Temperature	-55°C to +150°C
Lead Temperature (Soldering, 10sec.)	+300°C

Currents are positive into, negative out of the specified terminal. Consult Packaging Section of Databook for thermal limitations and considerations of package.

CONNECTION DIAGRAM



ELECTRICAL CHARACTERISTICS: Unless otherwise specified, VDD = 5V, TA = 0°C to 70°C for the UCC3919, -40°C to 85° for the UCC2919 and -55°C to 125°C for the UCC1919. All voltages are with respect to GND. TA = TJ.

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Input Supply					
Supply Current	VDD = 3V		0.5	1	mA
	VDD = 8V		1	1.5	mA
Shutdown Current	SD = 0.2V		1	5	µA
Undervoltage Lockout					
Minimum Voltage to Start		2.5	2.75	3	V
Minimum Voltage after Start		2	2.25	2.5	V
Hysteresis		0.25	0.5	0.75	V
IBIAS					
Output Voltage (IOUT = 1mA)	25°C, referred to CS+	1.47	1.5	1.53	V
	Over Temperature Range, referred to CS+	1.44	1.5	1.56	V
Maximum Output Current		1	2		mA
Maximum Bypass Capacitance				2	nF
Current Sense					
Over Current Comparator Offset	Referred to CS+	-55	-50	-45	mV
Linear Current Amplifier Offset	VIMAX = 100mV, Referred to CS+	-120	-100	-80	mV
	VIMAX = 400mV, Referred to CS+	-440	-400	-360	mV
Overload Comparator Offset	VIMAX = 100mV, Referred to CS+	-360	-300	-240	mV
CS- Input Voltage Range	Referred to VDD, 3V ≤ VDD ≤ 8V	-1.5		0.2	V
CS+ Input Voltage Range	Referred to VDD, 3V ≤ VDD ≤ 8V	0		0.2	V
Input Bias Current CS-			1	5	µA
Input Bias Current CS+			100	200	µA

ELECTRICAL CHARACTERISTICS (cont.): Unless otherwise specified, VDD = 5V, TA = 0°C to 70°C for the UCC3919, -40°C to 85°C for the UCC2919 and -55°C to 125°C for the UCC1919. All voltages are with respect to GND. TA = TJ.

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Current Fault Timer					
CT Charge Current	VCT = 1V	-56	-35	-16	μA
CT Discharge Current	VCT = 1V	0.5	1.2	1.9	μA
On Time Duty Cycle in Fault	IPL = 0	2	3.3	5	%
CT Fault Threshold		1.3	1.5	1.7	V
CT Reset Threshold		0.4	0.5	0.6	V
IMAX					
Input Bias Current		10	16	22	μA
Power Limiting Section					
Voltage on PL	IPL = -250μA, Referred to VDD	-0.10	-0.15	-0.25	V
	IPL = -1.5mA, Referred to VDD	-0.5	-0.9	-1.5	V
On Time Duty Cycle in Fault	IPL = 0μA	2	3.3	5	%
	IPL = -250μA	0.5	1	2	%
	IPL = -1.5mA	0.05	0.1	0.2	%
SD and L/R Inputs					
Input Voltage Low				0.8	V
Input Voltage High		2			V
FLT Output					
Output Leakage Current	VDD = 5V			10	μA
Output Low Voltage	IOUT = 10mA			1	V
FET GATE Driver and Charge Pump					
Peak Output Current		-2	-1.5	-1	mA
Peak Sink Current			100		mA
On Time During Fault			200		nS
Maximum Output Voltage	VDD = 3V, Average IOUT = 1μA	10	11	11.5	V
	VDD = 8V, Average IOUT = 1μA	13	14	15	V
Charge Pump Source Impedance	VDD = 5V, Average IOUT = 1μA		80		kΩ

PIN DESCRIPTIONS

CAP: A capacitor is placed from this pin to ground to filter the output of the on board charge pump. A 0.1μF capacitor is recommended .

CS-: The negative current sense input signal.

CS+: The positive current sense input signal.

CT: Input to the duty cycle timer. A capacitor is connected from this pin to ground, setting the off time and the maximum on time of the overcurrent protection circuits.

FLT: Fault indicator. This open drain output will pull low under any fault condition where the output driver is disabled. This output is disabled when the IC is in low current standby mode.

GATE: The output of the MOSFET driver. This pin drives the gate of an N-channel MOSFET pass transistor. The error amplifier/driver control loop is internally compensated, and guaranteed stable for output load (gate) capacitance between 100pF and 10nF.

GND: The ground reference for the device.

IBIAS: Output of the on board bias generator internally regulated to 1.5V below CS+. A resistor divider between this pin and CS+ can be used to generate the IMAX voltage. The bias circuit is internally compensated, and requires no bypass capacitance. If an external bypass is required due to a noisy environment, the circuit will be stable with up to 1nF of capacitance. The bypass must be to CS+, since the bias voltage is generated with respect to CS+.

IMAX: Used to program the maximum allowable sourcing current. The voltage on this pin is with respect to CS+. If the voltage across the shunt resistor exceeds this voltage a linear amplifier lowers the voltage at GATE to limit the output current to this level. If the voltage across the shunt resistor goes more than 200mV beyond this voltage, the gate drive pin GATE is immediately driven low and kept low for one full off time interval.

PIN DESCRIPTIONS (cont.)

L/R: Latch/Reset. This pin sets the reset mode. If L/R is low and a fault occurs the device will begin duty ratio current limiting. If L/R is high and a fault occurs, GATE will go low and stay low until L/R is set low. This pin is internally pulled low by a 3μA nominal pulldown.

PL: Power Limit. This pin is used to control average power dissipation in the external MOSFET. If a resistor is connected from this pin to the source of the external MOSFET, the current in the resistor will be roughly proportional to the voltage across the FET. As the voltage across the FET increases, this current is added to the fault timer charge current, reducing the on time duty cycle from its nominal value of 3% and limiting the average power dissipation in the FET.

SD: Shutdown pin. If this pin is taken low, GATE will go low, and the IC will go into a low current standby mode and CT will be discharged. This TTL compatible input must be driven high to turn on.

Shutdown Characteristics

When the SD pin is set to TTL high (above 2V) the UCC3919 is guaranteed to be enabled. When SD is set to

APPLICATION INFORMATION

The UCC3919 monitors the voltage drop across a high side sense resistor and compares it against three different voltage thresholds. These are discussed below. Figure 1 shows the UCC3919 waveforms under fault conditions.

Fault Threshold

The first threshold is fixed at 50mV. If the current is high enough such that the voltage on CS- is 50mV below CS+, the timing capacitor CT begins to charge at about 35μA if the PL pin is open. (Power limiting will be discussed later). If this threshold is exceeded long enough for CT to charge to 1.5V, a fault is declared and the external MOSFET will be turned off. It will either be latched off (until the power to the circuit is cycled, the L/R pin is taken low, or the SD pin is toggled), or will retry after a fixed off time (when CT has discharged to 0.5V), depending on whether the L/R pin is set high or low by the user. The equation for this current threshold is simply:

$$I_{\text{FAULT}} = \frac{0.05}{R_{\text{SENSE}}} \quad (1)$$

The first time a fault occurs, CT is at ground, and must charge 1.5V. Therefore:

$$t_{\text{FAULT}} = t_{\text{ONsec}} \cong \frac{C_{\text{T}}(\mu\text{F}) \cdot 1.5}{35} \quad (2)$$

a low TTL (below 0.8V) the UCC3919 is guaranteed to be disabled, but may not be in ultra low current sleep mode. When SD is set to 0.2V or less, the UCC3919 is guaranteed to be disabled and in ultra low current sleep mode.

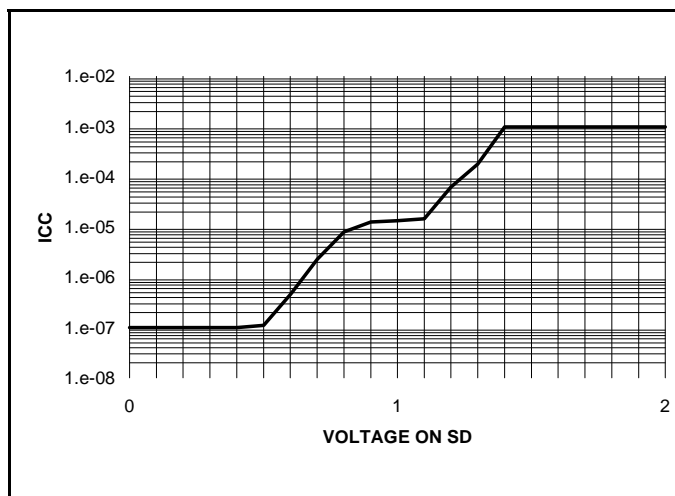


Figure 5. Typical Shutdown Current

VDD: The power connection for the device.

In the retry mode, the timing capacitor will already be charged to 0.5V at the end of the off time, so all subsequent cycles will have a shorter ton time, given by:

$$t_{\text{FAULT}} = t_{\text{ONsec}} \cong \frac{C_{\text{T}}(\mu\text{F})}{35} \quad (3)$$

Note that these equations for ton are without the power limiting feature (RPL pin open). The effects of power limiting on ton will be discussed later.

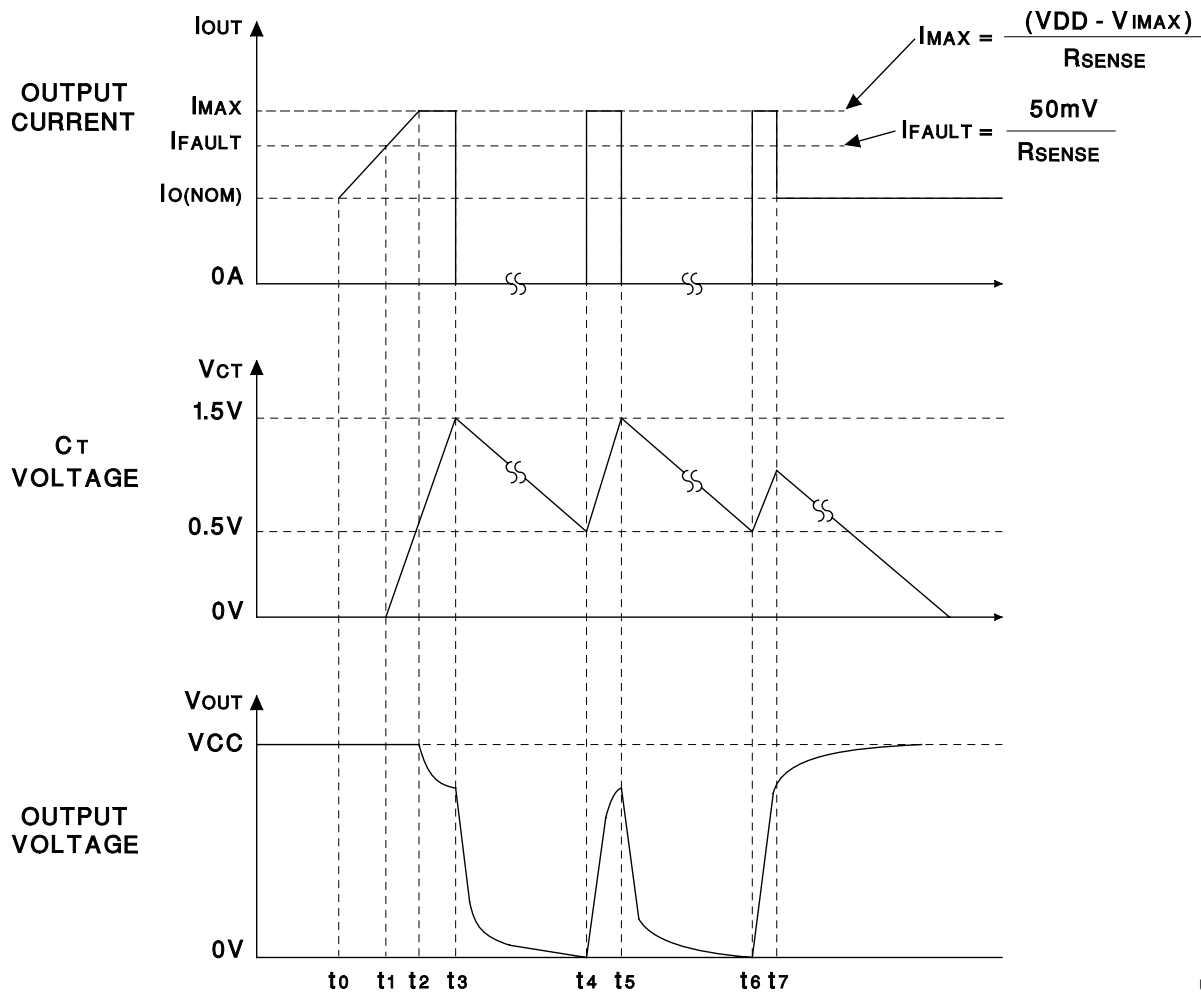
The off time in the retry mode is set by CT and an internal 1.2μA sink current. It is the time it takes CT to discharge from 1.5V to 0.5V. The equation for the off time is therefore:

$$t_{\text{OFFsec}} = \frac{C_{\text{T}}(\mu\text{F})}{1.2} \quad (4)$$

IMAX Threshold

The second threshold is programmed by the voltage on IMAX (measured with respect to the CS+ pin). This controls the maximum current, IMAX, that the UCC3919 will allow to flow into the load during the MOSFET on time. A resistive divider connected between IBIAS and CS+ generates the programming voltage. When the drop across the sense resistor reaches this voltage, a linear amplifier reduces the voltage on GATE to control the external MOSFET in a constant current mode.

APPLICATION INFORMATION (cont.)



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t0: Normal condition - Output current is nominal, output voltage is at positive rail, VCC.

t1: Fault control reached - Output current rises above the programmed fault value, CT begins to charge with $35\mu A + IPL$.

t2: Maximum current reached - Output current reaches the programmed maximum level and becomes a constant current with value I_{MAX}.

t3: Fault occurs - CT has charged to 1.5V, fault output goes low, the FET turns off allowing no output current to

flow, V_{OUT} discharges to GND.

t4: Retry - CT has discharged to 0.5V, but fault current is still exceeded, CT begins charging again, FET is on, V_{OUT} increases.

t3 to t5: Illustrates <3% duty cycle depending upon R_{PL} selected.

t6 = t4

t7: Fault released, normal condition - return to normal operation of the circuit breaker.

Figure 1. Typical Timing Diagram

APPLICATION INFORMATION (cont.)

During this time C_T is charging, as described above. If this condition lasts long enough for C_T to charge to 1.5V, a fault will be declared and the MOSFET will be turned off. The I_{MAX} current is calculated as follows:

$$I_{MAX} = \frac{V_{CS+} - V_{IMAX}}{R_{SENSE}} \quad (5)$$

Note that if the voltage on the I_{MAX} pin is programmed to be less than 50mV below $CS+$, then the UCC3919 will control the MOSFET in a constant current mode all the time. No fault will be declared and the MOSFET will remain on because I_{MAX} is less than I_{FAULT} .

Overload Threshold

There is a third threshold which, if exceeded, will declare a fault and shutdown the external MOSFET immediately, without waiting for C_T to charge. This "Overload" threshold is 200mV greater than the I_{MAX} threshold (again, this is with respect to $CS+$). This feature protects the circuit in the event that the external MOSFET is on, with a load current below I_{MAX} , and a short is quickly applied across the output. This allows hot-swapping in cases where the UCC3919 is already powered up (on the backplane) and capacitors are added across the output bus. In this case, the load current could rise too quickly for the linear amplifier to reduce the voltage on $GATE$ and limit the current to I_{MAX} . If the overload threshold is reached, the MOSFET will be turned off quickly and a fault declared. A latch is set so that C_T can be charged, guaranteeing that the MOSFET will remain off for the same period as defined above before retrying. The overload current is:

$$I_{OVERLOAD} = \frac{V_{CS+} - V_{IMAX} + 0.2}{R_{SENSE}} = I_{MAX} + \frac{0.2}{R_{SENSE}} \quad (6)$$

Note that $I_{OVERLOAD}$ may be much greater than I_{MAX} , depending on the value of R_{SENSE} .

Power Limiting

A power limiting feature is included which allows the power dissipated in the external MOSFET to be held relatively constant during a short, for different values of input voltage. This is accomplished by connecting a resistor from the output (source of the external MOSFET) to PL . When the output voltage drops due to a short or overload, an internal bias current is generated which is equal to:

$$I_{PL} \cong \frac{V_{IN} - V_{OUT}}{600 + R_{PL}} - \frac{0.1}{600}, \text{ for a shorted output:} \quad (7)$$

$$I_{PL} \cong \frac{V_{IN}}{600 + R_{PL}} - \frac{0.1}{600}$$

This current is used to help charge the timing capacitor in

the event that the load current exceeds I_{FAULT} . (A simplified schematic of the circuit internal to the UCC3919 is shown in Figure 2.) The result is that the on time of the MOSFET during current limit is reduced as the input voltage is increased. This reduces the effective duty cycle, holding the average power dissipated constant.

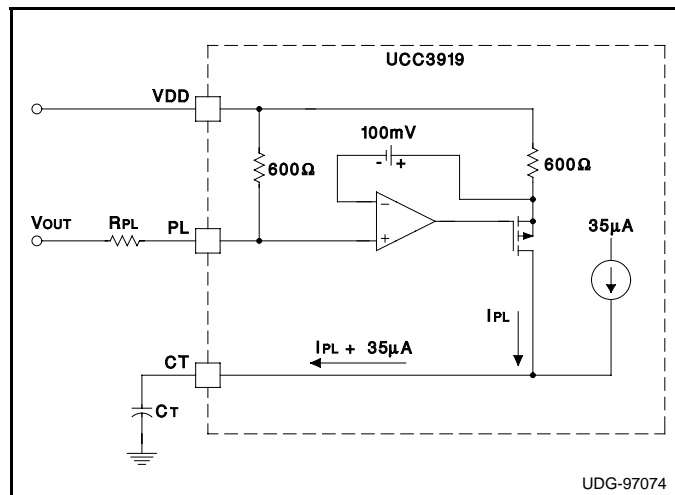


Figure 2. Power Limiting Circuit

It can be seen that power limiting will only occur when I_{PL} is > 0 (it cannot be negative). For power limiting to begin to occur, R_{PL} must be below a certain value for a given V_{IN} , as approximated by:

$$R_{PL}(k\Omega) < \frac{V_{IN}}{0.17} \quad (8)$$

The on time using R_{PL} is defined as:

$$t_{ON} = \frac{C_T}{I_{PL} + 35 \cdot 10^{-6}} \quad (9)$$

The graph in Figure 3 illustrates the effect of R_{PL} on the average MOSFET power dissipation into a short. The equation for the average power dissipation during a short is:

$$P_{DISS} = \frac{I_{MAX} \cdot V_{IN} \cdot 1.2 \cdot 10^{-6}}{I_{PL} + 35 \cdot 10^{-6}}, \text{ or} \quad (10)$$

$$P_{DISS} = \frac{I_{MAX} \cdot V_{IN} \cdot t_{ON}}{t_{ON} + t_{OFF}}$$

If PL is left unconnected, the power limiting feature will not be exercised. In the retry mode, the duty cycle during a fault will be nominally 3.3%, independent of input voltage. The average power dissipation in the external MOSFET with a shorted output will be proportional to input voltage, as shown by the equation:

$$P_{DISS} = I_{MAX} \cdot V_{IN} \cdot 0.033 \quad (11)$$

APPLICATION INFORMATION (cont.)

Calculating C_{Tmin} for a Given Load Capacitance without Power Limiting

To guarantee recovery from an overload when operating in the retry mode, there is a maximum total output capacitance which can be charged for a given t_{ON} (fault time) before causing a fault. For a worst case situation of a constant current load below the fault threshold, C_{Tmin} for a given output load capacitance (without power limiting) can be calculated from:

$$C_{Tmin} = \frac{V_{IN} \cdot C_{OUT} \cdot 35 \cdot 10^{-6}}{I_{MAX} - I_{LOAD}} \quad (12)$$

A larger load capacitance or a smaller C_T will cause a fault when recovering from an overload, causing the circuit to get stuck in a continuous hiccup mode. To handle larger capacitive loads, increase the value of C_T . The equation can be easily re-written, if desired, to solve for C_{OUTmax} for a given value of C_T .

For a resistive load of value R_L and an output cap C_{OUT} , C_{Tmin} can be smaller than in the constant current case, and can be estimated from:

$$C_{Tmin} = \frac{-C_{OUT} \cdot R_L \cdot 1n \left(1 - \frac{V_{IN}}{I_{MAX} \cdot R_L} \right)}{28 \cdot 10^3} \quad (13)$$

Note that in the latch mode (or when first turning on in the retry mode), since the timing capacitor is not recovering from a previous fault, it is charging from 0V rather than 0.5V. This allows up to 50% more load capacitance without causing a fault.

Estimating C_{Tmin} When Using Power Limiting

If power limiting is used, the calculation of C_{Tmin} for a given C_{OUT} becomes considerably more complex, especially with a resistive load. This is because the C_T charge current becomes a function of V_{OUT} , which is changing with time. The amount of capacitance that can be charged (without causing a fault) when using power limiting will be significantly reduced for the same value C_T , due to the shorter t_{on} time.

Equations will be given for making a conservative calculation of C_{Tmin} for constant current and resistive loads. To simplify the calculation, the following approximation will be made:

$$I_{PL} \cong \frac{V_{IN} - V_{OUT}}{R_{PL}} \quad (14)$$

This will yield a conservative value for C_{Tmin} , because the UCC3919's internal 600 Ω resistor and 100mV offset (shown in Figure 2) are being ignored.

Constant Current Load

For a constant current load, the output capacitor will charge linearly. During that time:

$$I_{PLavg} \cong \frac{V_{IN}}{2 \cdot R_{PL}} \quad (15)$$

Modifying equation (12) yields:

$$C_{Tmin} \cong \frac{V_{IN} \cdot C_{OUT} \cdot \left(\frac{V_{IN}}{2 \cdot R_{PL}} + 35 \cdot 10^{-6} \right)}{I_{MAX} - I_{LOAD}} \quad (16)$$

Resistive Load

Determining C_{Tmin} for a resistive load is more complex. First, the expression for the output voltage as a function of time is:

$$V_{OUT}(t) = I_{MAX} \cdot R_{LOAD} \cdot \left(1 - e^{-\frac{t}{R_{LOAD} \cdot C_{OUT}}} \right) \quad (17)$$

Solving for t when $V_{OUT} = V_{IN}$ yields:

$$t = -R_{LOAD} \cdot C_{OUT} \cdot \ln \left(1 - \left(\frac{V_{IN}}{I_{MAX} \cdot R_{LOAD}} \right) \right) \quad (18)$$

Assuming that the device is operating in the retry mode, where C_T is charging from 0.5V to just below 1.5V in time t , C_T is defined as:

$$C_T = \frac{I_{CT} \cdot dt}{dV} = I_{CT} \cdot dt \quad \text{where } I_{CT} = (I_{PL} + 35 \cdot 10^{-6}) \quad (19)$$

Substituting equation (14) and (19) yields:

$$C_{Tmin} = \left(\frac{V_{IN} - V_{OUT}}{R_{PL}} + 35 \cdot 10^{-6} \right) \cdot dt \quad (20)$$

Now substitute equation (17) for V_{OUT} and integrate (20) over time t . This yields the following expression for C_{Tmin} for a resistive load with power limiting:

$$C_{Tmin} \cong t \cdot \left(35 \cdot 10^{-6} + \left(\frac{V_{IN} - (I_{MAX} \cdot R_{LOAD})}{R_{PL}} \right) + \left(\frac{V_{IN} \cdot R_{LOAD} \cdot C_{LOAD}}{R_{PL}} \right) \right) \quad (21)$$

By substituting the value calculated for t in equation (18), C_{Tmin} is determined.

Example

The example in Figure 4 shows the UCC3919 in a typical application. A low value sense resistor and N-channel MOSFET minimize losses. With the values shown for R_1 ,

THERMAL CONSIDERATIONS (cont.)

The junction temperature of the MOSFET can be calculated from:

$$T_J = T_A + (P_{DISS} \cdot \theta_{JA}) \quad (32)$$

Where T_A is the ambient temperature and θ_{JA} is the MOSFET's thermal resistance from junction to ambient. If the device is on a heatsink, then the following equation applies:

$$\theta_{JA} = \theta_{JC} + \theta_{CS} + \theta_{SA} \quad (33)$$

Where θ_{JC} is the MOSFET's thermal resistance from junction to case, θ_{CS} is the thermal resistance from case to sink, and θ_{SA} is the thermal resistance of the heatsink to ambient.

The calculated T_J must be lower than the MOSFET's maximum junction temperature rating, therefore:

$$\theta_{JA} < \frac{T_{Jmax} - T_A}{P_{DISS}} \quad (34)$$

Transient Thermal Impedance

During a fault condition in the retry mode, the average MOSFET power dissipation will generally be quite low due to the low duty cycle, as defined by:

$$P_{DISSavg} = \frac{I_{MAX} \cdot V_{IN} \cdot t_{ON}}{t_{ON} + t_{OFF}} \quad (\text{With output shorted}) \quad (35)$$

(In the latch mode, t_{OFF} will be the time between a fault and the time the device is reset.)

However, the pulse power in the MOSFET during t_{ON} , with the output shorted, is:

$$P_{DISSpulse} = I_{MAX} \cdot V_{IN} \quad (\text{With output shorted}) \quad (36)$$

In choosing t_{ON} for a given V_{IN} , I_{MAX} , and duty cycle it is important to consult the manufacturer's transient thermal impedance curves for the MOSFET to make sure the device is within its safe operating area. These curves provide the user with the effective thermal impedance of the device for a given time duration pulse and duty cycle. Note that some of the impedance curves are normalized

SAFETY RECOMMENDATIONS

Although the UCC3919 is designed to provide system protection for all fault conditions, all integrated circuits can ultimately fail short. For this reason, if the UCC3919 is intended for use in safety critical applications where UL or some other safety rating is required, a redundant safety

device such as a fuse should be placed in series with the device. The UCC3919 will prevent the fuse from blowing for virtually all fault conditions, increasing system reliability and reducing maintenance cost, in addition to providing the hot swap benefits of the device.

to one, in which case the transient impedance values must be multiplied by the DC (steady state) thermal resistance, θ_{JC} .

For duty cycles not shown in the manufacturer's curves, the transient thermal impedance for any duty cycle and t_{ON} time (given a square pulse) can be estimated from [1]:

$$\theta_{JCtrans} = (D \cdot \theta_{JC}) + (1 - D) \cdot \theta_{SP} \quad (37)$$

Where D is the duty cycle

$$\frac{t_{ON}}{t_{ON} + t_{OFF}}$$

and θ_{SP} is the single pulse thermal impedance given in the transient thermal impedance curves for the time duration of interest (t_{ON}). Note that these are absolute numbers, not normalized. If the given single pulse impedance is normalized, it must first be multiplied by θ_{JC} before using in the equation above.

This effective transient thermal impedance, when multiplied by the pulse power, will give the transient temperature rise of the die. To keep the junction temperature below the maximum rating, the following must be true:

$$\theta_{JCtrans} < \frac{T_{Jmax} - T_C}{P_{DISSpulse}} \quad (38)$$

If necessary, the junction temperature rise can be reduced by reducing t_{ON} (using a smaller value for C_T), or by reducing the duty cycle using the power limiting feature already discussed. Note that in either case, the amount of load capacitance, C_{OUT} , that can be charged before causing a fault, will also be reduced.

References

- [1] International Rectifier, HEXFET Power MOSFET Designer's Manual, Application Note 949B, "Current Ratings, Safe operating Area, and High Frequency Switching Performance of Power HEXFET's", pp. 1553-1565, September 1993.